

# DM77/87SR181 (1024 x 8) 8k-Bit Registered TTL PROM

## **General Description**

The DM77/87SR181 is an electrically programmable Schottky TTL read-only memory with D-type, master-slave registers on chip. This device is organized as 1024-words by 8-bits and is available in the TRI-STATE® output version. Designed to optimize system performance, this device also substantially reduces the cost and size of pipelined microprogrammed systems and other designs wherein accessed PROM data is temporarily stored in a register. The DM77/87SR181 also offers maximal flexibility for memory expansion and data bus control by providing both synchronous and asynchronous output enables. All outputs will go into the "OFF" state if the synchronous chip enable (GS) is high before the rising edge of the clock, or if the asynchronous chip enable (G) is held high. The outputs are enabled when GS is brought low before the rising edge of the clock and G is held low. The GS flip-flop is designed to power up to the "OFF" state with the application of VCC.

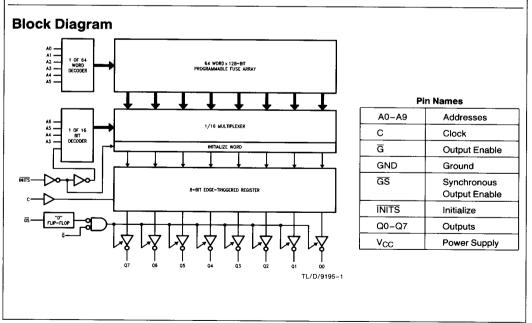
Data is read from the PROM by first applying an address to inputs A0-A9. During the setup time the output of the array is loaded into the master flip-flop of the data register. During the rising edge (low to high transition) of the clock, the data is then transferred to the slave of the flip-flop and will appear on the output if the output is enabled. Following the rising edge clock transition the addresses and synchronous chip enable can be removed and the output data will remain stable.

The DM77/87SR181 also features an initialize function INIT. The initialize function provides the user with an extra word of programmable memory which is accessed with single pin control by applying a low on INIT. The initialize function is synchronous and is loaded into the output register on the next rising edge of the clock. The unprogrammed state of the INIT is all lows.

PROMs are shipped from the factory with lows in all locations. A high may be programmed into any selected location by following the programming instructions. Once programmed, it is impossible to go back to a low.

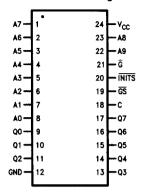
### **Features**

- On-chip, edge-triggered registers
- Synchronous and asynchronous enables for word expansion
- Programmable register initialize
- 24-pin, 300 mil package
- 40 ns address setup and 20 ns clock to output for maximum system speed
- Highly reliable, titanium tungsten fuses
- TRI-STATE outputs
- Low voltage TRI-SAFETM programming
- All parameters guaranteed over temperature



# **Connection Diagrams**

**Dual-In-Line Package** 



TL/D/9195-2

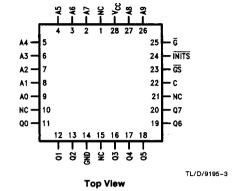
Top View
Order Number DM77/87SR181J or DM87SR181N
See NS Package Number J24A or N24A

# **Ordering Information**

Commercial Temp Range (0°C to +70°C)

| Parameter/Order Number |
|------------------------|
| DM87SR181J             |
| DM87SR181N             |
| DM87SR181V             |

### Plastic Leaded Chip Carrier (PLCC)



Order Number DM87SR181V See NS Package Number V28A

Military Temp Range (-55°C to +125°C)

| Parameter/Order Nun | nber |
|---------------------|------|
| DM77SR181J          |      |

| Absolute Maximum Ratings (Note   | 1)    |
|--|-------|
| If Military/Aerospace specified devices are re-<br>please contact the National Semiconductor<br>Office/Distributors for availability and specificati | Sales |

| Office/ Distributors for availability at | na specifications. |
|--|--------------------|
| Supply Voltage (Note 2)                  | -0.5V to $+7.0V$   |
| Input Voltage (Note 2)                   | -1.2V to $+5.5V$   |
| Output Voltage (Note 2)                  | -0.5V to $+5.5V$   |
| Storage Temperature                      | -65°C to +150°C    |
| Lead Temp. (Soldering, 10 seconds)       | 300°C              |

Note 1: Absolute maximum ratings are those values beyond which the device may be permanently damaged. They do not mean that the device may be operated at those values.

ESD rating to be determined.

Note 2: These limits do not apply during programming. For the programming settings, refer to the programming instructions.

| Operating Conditions                  |      |       |       |  |  |
|---------------------------------------|------|-------|-------|--|--|
|                                       | Min  | Max   | Units |  |  |
| Supply Voltage (V <sub>CC</sub> )     |      |       |       |  |  |
| Military                              | 4.50 | 5.50  | ٧     |  |  |
| Commercial                            | 4.75 | 5.25  | ٧     |  |  |
| Ambient Temperature (T <sub>A</sub> ) |      |       |       |  |  |
| Military                              | -55  | + 125 | °C    |  |  |
| Commercial                            | 0    | + 70  | °C    |  |  |
| Logical "0" Input Voltage             | 0    | 8.0   | V     |  |  |
| Logical "1" Input Voltage             | 2.0  | 5.5   | V     |  |  |

# DC Electrical Characteristics (Note 1)

| Symbol          | Parameter                       | Conditions   | DM77SR181 |      |      | DM87SR181 |      |      |       |
|-----------------|---------------------------------|--|-----------|------|------|-----------|------|------|-------|
|                 |                                 |  | Min       | Тур  | Max  | Min       | Тур  | Max  | Units |
| կլ              | Input Load Current              | V <sub>CC</sub> = Max, V <sub>IN</sub> = 0.45V                                 |           | -80  | -250 |           | -80  | -250 | μΑ    |
| I <sub>IH</sub> | Input Leakage Current           | V <sub>CC</sub> = Max, V <sub>IN</sub> = 2.7V                                  |           |      | 25   |           |      | 25   | μΑ    |
|                 |                                 | V <sub>CC</sub> = Max, V <sub>IN</sub> = 5.5V                                  |           |      | 1.0  |           |      | 1.0  | mA    |
| V <sub>OL</sub> | Low Level Output Voltage        | V <sub>CC</sub> = Min, I <sub>OL</sub> = 16 mA                                 |           | 0.35 | 0.50 |           | 0.35 | 0.45 | V     |
| V <sub>IL</sub> | Low Level Input Voltage         |  |           |      | 0.80 |           |      | 0.80 | v     |
| V <sub>IH</sub> | High Level Input Voltage        |  | 2.0       |      |      | 2.0       |      |      | v     |
| V <sub>C</sub>  | Input Clamp Voltage             | V <sub>CC</sub> = Min, I <sub>IN</sub> = -18 mA                                | -         | -0.8 | -1.2 |           | -0.8 | -1.2 | V     |
| Cı              | Input Capacitance               | V <sub>CC</sub> = 5.0V, V <sub>IN</sub> = 2.0V<br>T <sub>A</sub> = 25°C, 1 MHz |           | 4.0  |      |           | 4.0  |      | pF    |
| CO              | Output Capacitance              | $V_{CC} = 5.0V$ , $V_{O} = 2.0V$<br>$T_{A} = 25^{\circ}C$ , 1 MHz, Outputs Off |           | 6.0  |      |           | 6.0  |      | pF    |
| Icc             | Power Supply Current            | V <sub>CC</sub> = Max, Inputs Grounded<br>All Outputs Open                     |           | 115  | 175  |           | 115  | 175  | mA    |
| los             | Short Circuit<br>Output Current | V <sub>O</sub> = 0V, V <sub>CC</sub> = Max<br>(Note 2)                         | -20       |      | -70  | -20       |      | -70  | mA    |
| loz             | Output Leakage<br>(TRI-STATE)   | V <sub>CC</sub> = Max, V <sub>O</sub> = 0.45V to 2.4V<br>Chip Disabled         | -50       |      | + 50 | -50       |      | +50  | μΑ    |
| V <sub>OH</sub> | Output Voltage High             | $I_{OH} = -2.0 \text{ mA}$   | 2.4       | 3.2  |      |           |      |      |       |
|                 |                                 | $I_{OH} = -6.5 \text{mA}$  |           |      |      | 2.4       | 3.2  |      | V     |

Note 1: These limits apply over the entire operating range unless otherwise noted. All typical values are for V<sub>CC</sub> = 5.0V and T<sub>A</sub> = 25°C.

Note 2: During IOS measurement, only one output at a time should be grounded. Permanent damage may otherwise result.

#### Switching Characteristics DM77SR181 DM87SR181 Symbol **Parameter** Conditions Units Min Typ Max Min Тур Max Address to C (High) Setup Time $C_1 = 30 pF$ 50 20 40 20 ns ts(A) 0 -5 o -5 Address to C (High) Hold Time ns t<sub>H(A)</sub> INITS to C (High) Setup Time 35 20 30 20 ns ts(INITS) n -5 0 INITS to C (High) Hold Time -5 th(INITS) ns Delay from C (High) tPHL(C) 15 30 15 20 ns to Output (High or Low) tPLH(C) C Width (High or Low) twH(C) 20 25 13 13 กร tWL(C) 15 0 15 0 ts(GS) GS to C (High) Setup Time ns 5 5 0 GS to C (High) Hold Time 0 ns t<sub>H(GS)</sub> $C_1 = 30 pF$ Delay from C (High) tpzL(C) 20 30 20 25 ns to Active Output (High or Low) t<sub>PZH(C)</sub>

 $C_L = 5 pF (Note 1)$ 

Note: All typical values are for V<sub>CC</sub> = 5V, T<sub>A</sub> = 25°C.

Delay from G (Low)

Delay from C (High)

Delay from G (High)

to Active Output (Low or High)

to Inactive Output (TRI-STATE)

to Inactive Output (TRI-STATE)

## **Functional Description**

#### **TESTABILITY**

tPZL(G)

tpZH(G)

t<sub>PLZ(C)</sub>

t<sub>PHZ</sub>(C)

tPLZ(G)

tpHZ(G)

The Schottky PROM die includes extra rows and columns of fusable links for testing the programmability of each chip. These test fuses are placed at the worst-case chip locations to provide the highest possible confidence in the programming tests in the final product. A ROM pattern is also permanently fixed in the additional circuitry and coded to provide a parity check of input address levels. These and other test circuits are used to test for correct operation of the row and column-select circuits and functionality of input and enable gates. All test circuits are available at both wafer and assembled device levels to allow 100% functional and parametric testing at every stage of the test flow.

### RELIABILITY

As with all National products, the Ti-W PROMs are subjected to an on-going reliability evaluation by the Reliability Assurance Department. These evaluations employ accelerated life tests, including dynamic high-temperature operating life, temperature-humidity life, temperature cycling, and thermal shock. To date, nearly 7.4 million Schottky Ti-W PROM device hours have been logged, with samples in Epoxy B molded DIP (N-package), PLCC (V-package) and CERDIP (J-package). Device performance in all package configurations is excellent.

### **TITANIUM-TUNGSTEN FUSES**

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National's Programmable Read-Only Memories (PROMs) feature titanium-tungsten (Ti-W) fuse links designed to program efficiently with only 10.5V applied. The high performance and reliability of these PROMs are the result of fabrication by a Schottky bipolar process, of which the titanium-tungsten metallization is an integral part, and the use of an on-chip programming circuit.

30

30

30

15

20

15

25

25

25

ns

ns

ns

A major advantage of the titanium-tungsten fuse technology is the low programming voltage of the fuse links. At 10.5V, this virtually eliminates the need for guard-ring devices and wide spacings required for other fuse technologies. Care is taken, however, to minimize voltage drops across the die and to reduce parasitics. The device is designed to ensure that worst-case fuse operating current is low enough for reliable long-term operation. The Darlington programming circuit is liberally designed to insure adequate power density for blowing the fuse links. The complete circuit design is optimized to provide high performance over the entire operating ranges of V<sub>CC</sub> and temperature.